Searcn Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/537,436	AOCHI ET AL.	
Examiner	Art Unit	
Chau N. Nguyen	2831	

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	SEARCHED		
Class	Subclass	Date	Examiner
174	94R	11/4/2005	CN
439	45		
	75		
361	791	4/21/2006	CN
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH I (INCLUDING SEAR		)
	DATE	EXMR
Text	11/4/2005	CN
Text	4/21/2006	CŅ
Text	10/6/2006	CN
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